

# FPC Connector, 0.5mm Pitch, Connector SMT Type

#### SCOPE

#### 1.1. CONTENTS

This specification covers the performance, tests and quality requirements for the FPC Connector, 0.5mm Pitch Connector SMT Type.

#### 1.2. QUALIFICATION

When tests are performed on the subject product line, the procedures specified in TE 109 series specifications shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

#### 2. APPLICABLE DOCUMENT

The following TE documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

## 2.1. TE SPECIFICATIONS

A. 109-1: General Requirements for the Test Specification

B. 109-197: TE Specification vs EIA and IEC Test Methods

C. 501-57598: Test Report

## 3. REQUIREMENTS

## 3.1. DESIGN AND CONSTRUCTION

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

## 3.2. MATERIALS

A. Housing: Thermoplastic, UL94V-0

B. Actuator: Thermoplastic, UL94 V-0

C. Contact: Copper Alloy, Tin Plating or Gold Plating over Nickel under-plating.

D. Hold Down: Copper Alloy, Tin Plating over Nickel under-plating.

## 3.3. RATINGS

A. Voltage: 250 VAC

B. Current: 0.5 A Max

C. Temperature: - 40 °C to 85 °C



## 3.4. PERFOMANCE REQUEIREMENT AND TEST DESCRIPTION

The product shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1. All tests shall be performed at ambient environmental conditions per AMP Specification 109-1TEST REQUIREMENTS AND PROCEDURES SUMMARY.

## 3.5. TEST REQUIREMENTS AND PROCEDURES SUMMARY

Test Item		Requirement	Procedure								
1	Examination of Product	Meets requirements of product	Visual inspection.								
ı	Examination of Product	drawing. No physical damage.	No physical damage								
	ELECTRICAL REQUIREMENT										
		35m $Ω$ . Max.	Subject mated contacts assembled in								
2	Contact Resistance		housing to 20 mV DC Max open circuit at								
	Contact Nesistance		100mA								
			MIL-STD-1344A Method 3002.1								
	Insulation Resistance	100M Ohm Min.(Initial)	Impressed voltage 500VDC. The insulation								
		50M Ohm Min. ( Final)	resistance shall be measured between 10								
3			adjacent 10 opposing contacts per FPC								
			connector.								
			MIL-STD-202F, Method 302								
	Dielectric	No creeping discharge or	250VAC for 1minute								
4	Withstanding	flashover shall occur.	Test between adjacent circuits of unmated								
	Resistance	Current leakage:0.5mA MAX	connector.								
			MIL-STD-202F Method 301								
	MECHANICAL REQUIREMENT										
	Test Item	Requirement	Procedure								
5	Durability	See Note	Operation Speed: 25.4mm/minute								
			Durability Cycles:15 Cycles								
	Vibration	No electrical discontinuity	(1)Test duration:3 hours along								
		greater than 1microsecond shall	Each of 3 mutually perpendicular								
6		occur.	Plans(9hours totally)								
		See Note.	(2)Test board thickness:1.6±0.02mm								
			MIL-STD-1344A,Method 2005								
	Physical Shock	During and after each shock,	(1)Number of drops:3 drops in each of 3								
7		the contacts shell be no	mutually perpendicular planes								
<b>'</b>		discontinuity	(2)Test board thickness:1.6±0.02mm								
		greater then 1 microsecond.	MIL-STD-202F,Method 213.								
	Contact Retention	250 gf min.	The test shall be performed 10PCS of each								
8	Force		different row of contacts the crosshead								
0			speed should be less than 20mm per								
			minute.								
	Solder ability	Wet solder coverage:95% Min.	Solder Temp.:235±5°C								
9			Duration: 5±0.5sec.								
			MIL-STD-202F,Method 208D.								
	Figure 1 (cont)										

Figure 1 (cont)



MECHANICAL REQUIREMENT								
Test Item		Requirement	Procedure					
10	Humidity	See Note	(a)test condition:B (b)relative humidity:90±5% (c)temperature:40±3°C (d)test duration:96 hours Within one hour after exposure					
11	Salt Spray	No detrimental corrosion allowd in contact area and base metal exposed.	MIL-STD-202F,Method 103B.  Subject mated connectors to 35±2°C and 5±1% salt(NaCl) for 48hrs. After test, rinse the sample with water and recondition the room temperature for 48hrs.  MIL-STD-202F,Method 101D.1. condition B.					
12	Thermal Shock	See Note	(a)temperature range: -55±5°C to +85±5°C (b)time at each temperature: 30minutes (c)transfer time:5 minutes max. (d)number of cycles:5 cycles EIA-364-32C.					
13	Temperature Life	See Note	(a)test temperature:125±2°C (b)test duration:96 hours EIA-364-17B					
14	Resistance to Reflow Soldering Heat	No physical damage shall occur. (Lead-Free)	Pre-soak condition, 85°C/85% RH for 168 hours. Pre Heat: 150~180°C, 90±30sec. Heat: 230°C Min., 30±10sec. Peak Temp.: 260+0/-5°C, 20~40sec. Duration: 3 cycles TE spec. 109-201, Condition B					

Figure 1 (End)

NOTE: Shall meet visual requirements, show no physical damage, and meet requirement of additional tests as specified in the test sequence in Figures 2



3.6. PRODUCT QUALIFICATION AND REQUALIFICATION TEST

	Test Group									
Test or Examination	Α	В	С	D	Е	F	G	Н	I	
		Test Sequence (a)								
Examination of Product		1,9	1,9	1,7	1,3	1,6	1,3	1,3	1,5	
Contact Resistance	2,6	2.6	2,6	2,6		2,5			2,4	
Insulation Resistance	3,7	3,7	3,7	3,5						
Dielectric Withstanding Resistance	4,8	4,8	4,8	4						
Durability										
Vibration						3				
Physical Shock						4				
Contact Retention Force					2					
Solder ability							2			
Humidity	5									
Salt Spray		5								
Thermal Shock								2		
Temperature Life			5							
Resistance To Reflow Soldering Heat									3	

Figure 2

NOTE: (a) Numbers indicate sequence in which tests are performed.

(b) Discontinuities shall not take place in this test group, during tests.

单击下面可查看定价,库存,交付和生命周期等信息

>>TE Connectivity(泰科)